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_	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/724,341	KOPP ET AL.
	Examiner	Art Unit
	Dennis-Doon Chow	2629

SEARCHED				
Class	Subclass	Date	Examiner	
345	44	6/24/2006	сноw	
	82			
	76			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST	6/24/2006	сноw
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